

Antenna-Coupled Terahertz Microbolometers with Meander Structures: the Comparison of Titanium and Platinum Thermistors

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Abstract— Uncooled terahertz (THz) detectors with low noise-equivalent power (NEP) are especially important for the application of non-destructive sensing in many fields. Antenna-coupled THz microbolometers with meander thermistors of titanium (Ti) and Platinum (Pt) are studied to develop room-temperature THz detectors. The responsivity and NEP of the microbolometer with a meander Ti thermistor are much improved for 1 THz irradiation in comparison with those of the previous one with a straight Ti thermistor. The THz performance of the meander Ti bolometer is much better than the one with a meander Pt thermistor. Those results can be explained by the increase of the thermistor resistance and temperature coefficient of resistance (TCR) through innovating the meander line and also improving the fabrication process based on the electron beam (EB) lithography.

I. INTRODUCTION

DEVELOPMENT of THz detectors with low noise-equivalent power (NEP) is important in wide fields of applications. Room-temperature detectors in frequencies lower than 1 THz are especially indispensable for non-destructive sensing in industry, security, medicine and so on. Moreover, if the THz direct detectors with the performance enough for passive sensing of room-temperature objects are developed, it will bring the breakthrough to the application of THz waves.

To solve this issue, we have proposed a room-temperature antenna-coupled microbolometer, comprising of a dipole antenna, a heater connected to it at its center and a thermistor electrically insulated and thermally contacted to them^{1), 2)}, fabricated the devices on a high-resistivity silicon (Si) wafer by the electron beam (EB) lithography process³⁾ and evaluated them by THz experiments. We have displayed our detectors have optical performances at 1 THz comparable to the good room-temperature THz detectors⁴⁾.

In this study, we studied antenna-coupled microbolometers with meander thermistors to obtain higher responsivity and low NEP's by making large resistance of thermistor.

II. DESIGN, FABRICATION AND EXPERIMENTS

The configurations of the antenna-coupled microbolometers with meander thermistors are shown in Figs. 1 and 2. The widths and lengths of the meander line of the titanium (Ti) or platinum (Pt) thermistors are 0.1 μm and 90 μm and 0.2 μm and 49 μm as shown in the figures.

The Ti heater is used because Ti has relatively large

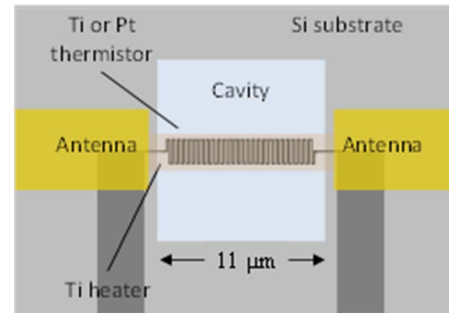


Fig. 1. Configurations of antenna-coupled microbolometers with a 0.1 μm -wide meander thermistor of titanium or platinum.

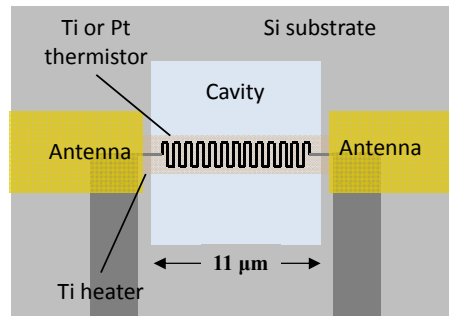


Fig. 2. Configurations of antenna-coupled microbolometers with a 0.2 μm -wide meander thermistor of titanium or platinum.

resistivity in all metals and the bulk resistivity of Ti is 4-time larger than that of Pt. The resistivity of thin lines of Ti was 7.5 time larger and the temperature coefficient of resistance (TCR) was smaller by 1/8 times compared with the bulk value in the previous study, but it brings almost no bad effect to the heater performance. The Pt thermistor is studied besides the Ti thermistor adopted in the previous study, because Pt is more stable to oxidation and acid-base reaction in the fabrication process. Insulation layers of SiN_x for the Ti and Pt thermistors are also studied to compare them with the SiO_2 insulation layer.

The heater of Ti is directly connected to the antennas made of gold (Au). The length of the dipole antenna including a Ti heater is 52 μm which fits to resonance length of a half wavelength of 1 THz wave on the Si surface.

The electron beam (EB) lithography process is applied to all the lithographic steps in the device fabrication.

The electrical experiments have been made to measure

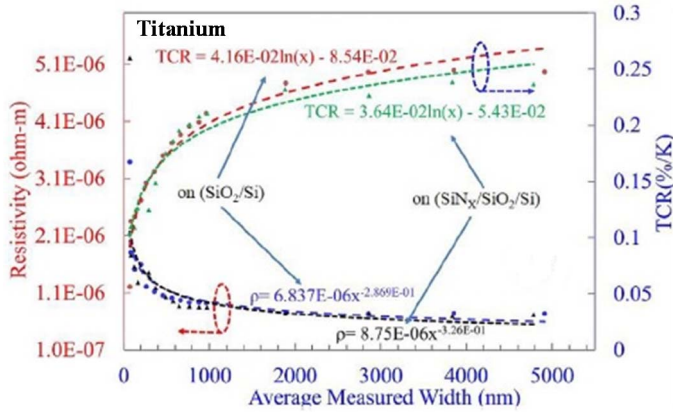


Fig. 3. Resistivity and temperature coefficient of resistance (TCR) as a function of averaged measured width of Ti line fabricated in this study. Results of insulation layers of SiO₂ and SiN_x are also displayed in the figure (Ref. 6).

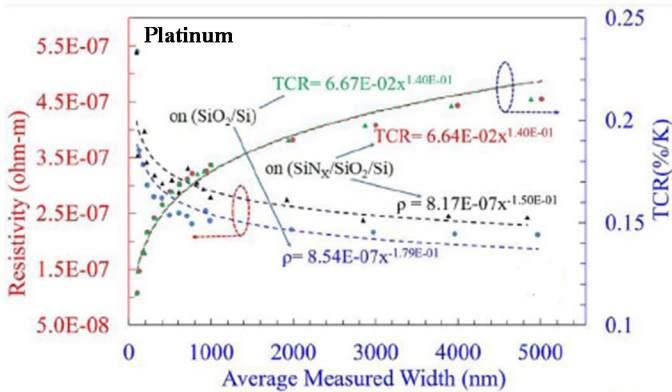


Fig. 4. Resistivity and temperature coefficient of resistance (TCR) as a function of averaged measured width of Pt line fabricated in this study. Results of insulation layers of SiO₂ and SiN_x are also displayed in the figure (Ref. 6).

resistivity, TCR, thermal conductance, noise, and electrical responsivity⁵). In the experiment, alternating current (AC) is supplied to the heater to give modulation of Joule heating, and the modulated output AC voltage is measured at the thermistor under a bias direct current (DC).

Furthermore, the optical experiments are made to measure responsivity to THz radiation from a 1 THz Schottky-diode multiplier source and the noise under background radiation at room-temperature by using a low-noise pre-amplifier, and the NEP is evaluated for a thermistor current of 0.1 mA.

III. RESULTS

The resistivity and TCR of Ti line are displayed for both the insulation layers of SiO₂ and SiN_x as functions of the line width in Fig. 3. The results show that the resistivity increases and the TCR decreases as the line width decreases, and also the differences in the resistance and TCR are small between the two insulation layers.

The increase in resistivity is about 4 times and the decrease in TCR is about 1/3 times between 100 nm wide line and bulk material value, which shows the deterioration is eased compared with the previous study. These good results are produced by the improvement in the fabrication process.

Figure 4 displays the resistivity and TCR of Pt line as functions of the line width for insulation layers of SiO₂ and

SiN_x. This figure shows the Pt line has also large dependence in both the resistivity and TCR on the line width and the small difference between the insulation layers.

The ratio of resistivity between Pt and Ti lines is about 1/6 in 100-200 nm width, which is smaller than 1/4 of the ratio between Pt and Ti bulks. This means that the electric property in the Pt line is less suffered by the fabrication process compared with the Ti line. The TCR of the Pt line is, however, almost the same with that of the Ti line in 100-200 nm width, which is similar with the almost common TCR of the bulk metals of about 0.3 %.

The resistances of Ti and Pt thermistors of 0.1 μm wide and 90 μm long meander lines in the THz antenna-coupled microbolometers are 16 kΩ and 4 kΩ respectively. The THz responsivity of Ti's is 36 time higher than that of Pt's. The noise of the Ti's was 4 time larger than the Pt's. If the THz radiation power within the area equal to square of the wavelength on the Si surface (119 μm for 1 THz) is absorbed, the NEP of the antenna-coupled microbolometers with Ti and Pt meander thermistors are 1.8 × 10⁻¹⁰ W/Hz^{1/2} and 1.5 × 10⁻⁹ W/Hz^{1/2} respectively, which shows the Ti's is 12 time better than the Pt's. It is improved by 2.5 times compared with the previous study⁴). These results can be explained by the increase in the resistance and TCR of Ti lines of 100 nm order⁵, ⁶).

The THz responsivity of the antenna-coupled microbolometer with Ti thermistor is consistent with the electrical measurement. It is also consistent with the theoretical analysis using the effective area of antenna deduced by the electromagnetic simulation and the area in which the antenna absorbs the THz irradiation.

IV. SUMMARY

We have studied a THz antenna-coupled microbolometer with a meander-line thermistor having large resistance and TCR to realize a room-temperature THz detector with low NEP. The new detector with a meander Ti thermistor has shown NEP improved by 2.5 times compared with the previous detector with a straight thermistor.

ACKNOWLEDGEMENT

This work was supported by the JSPS KAKENHI Grant Number JP15H03990. Grant-in-Aid for Scientific Research (B), the JST Industry-Academia Collaborative R&D Program (Collaborative Research Based on Industrial Demand), "Terahertz-wave: Towards Innovative Development of Terahertz-wave Technologies and Applications", and the Cooperative Research Project of the Research Center for Biomedical Engineering with Research Institute of Electronics, Shizuoka University.

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